

## **MOSFET**

Metal Oxide Semiconductor Field Effect Transistor

## CoolMOS™ C7

600V CoolMOS™ C7 Power Transistor IPZ60R060C7

## **Data Sheet**

Rev. 2.0 Final



### 1 Description

CoolMOS™ C7 is a revolutionary technology for high voltage power MOSFETs, designed according to the superjunction (SJ) principle and pioneered by Infineon Technologies.

600V CoolMOS™ C7 series combines the experience of the leading SJ MOSFET supplier with high class innovation.

The 600V C7 is the first technology ever with R<sub>DS(on)</sub>\*A below 10hm\*mm<sup>2</sup>.

#### **Features**

- Suitable for hard and soft switching (PFC and high performance LLC)
- Increased MOSFET dv/dt ruggedness to 120V/ns
- Increased efficiency due to best in class FOM RDS(on)\*Eoss and RDS(on)\*Qg
- Best in class R<sub>DS(on)</sub> /package
- · Easy to use/drive
- Pb-free plating, halogen free mold compound
- Qualified for industrial grade applications according to JEDEC (J-STD20 and JESD22)
- · 4pin kelvin source concept

#### **Benefits**

- Increased economies of scale by use in PFC and PWM topologies in the application
- Higher dv/dt limit enables faster switching leading to higher efficiency
- Enabling higher system efficiency by lower switching losses
- Increased power density solutions due to smaller packages
- Suitable for applications such as server, telecom and solar
- Up to 0.5% better full load efficiency @100kHz compared to conventional 3pin package

#### **Applications**

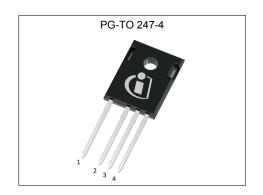
PFC stages and PWM stages (TTF, LLC) for high power/performance SMPS e.g. Computing, Server, Telecom, UPS and Solar.

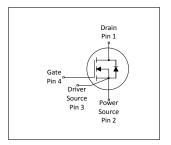
Please note: For MOSFET paralleling the use of ferrite beads on the gate or separate totem poles is generally recommended.



Table 1 Rey 1 chombanee 1 arameters								
Parameter	Value	Unit						
V <sub>DS</sub> @ T <sub>j,max</sub>	650	V						
R <sub>DS(on),max</sub>	60	mΩ						
Q <sub>g.typ</sub>	68	nC						
I <sub>D,pulse</sub>	135	A						
I <sub>D,continuous</sub> @ T <sub>j</sub> <150°C	54	A						
E <sub>oss</sub> @400V	8.1	μJ						
Body diode di/dt	400	A/µs						

Type / Ordering Code	Package	Marking	Related Links
IPZ60R060C7	PG-TO 247-4	60C7060	see Appendix A

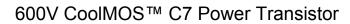














### IPZ60R060C7

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est Circuits
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**2** Maximum ratings at  $T_j = 25$ °C, unless otherwise specified

Table 2 **Maximum ratings** 

Parameter.	0	Values				Note / Took Open differen	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Continuous drain current <sup>1)</sup>	I <sub>D</sub>	-	-	35 22	А	T <sub>C</sub> =25°C T <sub>C</sub> =100°C	
Pulsed drain current <sup>2)</sup>	I <sub>D,pulse</sub>	-	-	135	Α	T <sub>C</sub> =25°C	
Avalanche energy, single pulse	<b>E</b> AS	-	-	159	mJ	I <sub>D</sub> =6.4A; V <sub>DD</sub> =50V; see table 10	
Avalanche energy, repetitive	<b>E</b> AR	-	-	0.80	mJ	I <sub>D</sub> =6.4A; V <sub>DD</sub> =50V; see table 10	
Avalanche current, single pulse	I <sub>AS</sub>	-	-	6.4	Α	-	
MOSFET dv/dt ruggedness	dv/dt	-	-	120	V/ns	V <sub>DS</sub> =0400V	
Gate source voltage (static)	V <sub>GS</sub>	-20	-	20	V	static;	
Gate source voltage (dynamic)	V <sub>GS</sub>	-30	-	30	V	AC (f>1 Hz)	
Power dissipation	P <sub>tot</sub>	-	-	162	W	<i>T</i> <sub>C</sub> =25°C	
Storage temperature	$T_{ m stg}$	-55	-	150	°C	-	
Operating junction temperature	T <sub>j</sub>	-55	-	150	°C	-	
Mounting torque	-	-	-	60	Ncm	M3 and M3.5 screws	
Continuous diode forward current	I <sub>S</sub>	-	-	35	Α	<i>T</i> <sub>C</sub> =25°C	
Diode pulse current <sup>2)</sup>	I <sub>S,pulse</sub>	-	-	135	Α	<i>T</i> <sub>C</sub> =25°C	
Reverse diode dv/dt <sup>3)</sup>	dv/dt	-	-	20	V/ns	$V_{\rm DS}$ =0400V, $I_{\rm SD}$ <=9.9A, $T_{\rm j}$ =25°C see table 8	
Maximum diode commutation speed		A/μs	$V_{\rm DS}$ =0400V, $I_{\rm SD}$ <=9.9A, $T_{\rm j}$ =25°C see table 8				
Insulation withstand voltage	V <sub>ISO</sub>	-	-	n.a.	V	V <sub>rms</sub> , T <sub>C</sub> =25°C, t=1min	

 $<sup>^{1)}</sup>$  Limited by  $T_{j\,\text{max}}.$   $^{2)}$  Pulse width  $t_p$  limited by  $T_{j,\text{max}}$   $^{3)}$  Identical low side and high side switch



### 3 Thermal characteristics

### **Table 3** Thermal characteristics

Davamatav	Cumbal	Values				N	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Thermal resistance, junction - case	R <sub>thJC</sub>	-	-	0.772	°C/W	-	
Thermal resistance, junction - ambient		-	-	62	°C/W	leaded	
Thermal resistance, junction - ambient for SMD version	R <sub>thJA</sub>	-	-	-	°C/W	n.a.	
Soldering temperature, wavesoldering only allowed at leads	T <sub>sold</sub>	-	-	260	°C	1.6mm (0.063 in.) from case for 10s	



# **4 Electrical characteristics** at $T_j$ =25°C, unless otherwise specified

Table 4 **Static characteristics** 

Danamatan	Correction I		Values			N	
Parameter	Symbol	Min.			Unit	Note / Test Condition	
Drain-source breakdown voltage	-source breakdown voltage $V_{(BR)DSS}$		-	-	V	$V_{GS}$ =0V, $I_{D}$ =1mA	
Gate threshold voltage	$V_{(GS)th}$	3	3.5	4 V V <sub>DS</sub> =V <sub>GS</sub>		$V_{\rm DS}=V_{\rm GS},\ I_{\rm D}=0.8{\rm mA}$	
Zero gate voltage drain current	I <sub>DSS</sub>	-	- 10	1 -	μΑ	V <sub>DS</sub> =600, V <sub>GS</sub> =0V, T <sub>j</sub> =25°C V <sub>DS</sub> =600, V <sub>GS</sub> =0V, T <sub>j</sub> =150°C	
Gate-source leakage current	I <sub>GSS</sub>	_	-	100	nA	V <sub>GS</sub> =20V, V <sub>DS</sub> =0V	
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	0.052 0.115	0.060	Ω	V <sub>GS</sub> =10V, I <sub>D</sub> =15.9A, T <sub>j</sub> =25°C V <sub>GS</sub> =10V, I <sub>D</sub> =15.9A, T <sub>j</sub> =150°C	
Gate resistance R <sub>G</sub>		-	0.8	-	Ω	f=1MHz, open drain	

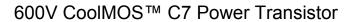
Table 5 **Dynamic characteristics** 

Danamatan	Ob. a.l	Values			11	Note / Took Condition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Input capacitance	Ciss	-	2850	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =400V, f=250kHz	
Output capacitance	Coss	-	54	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =400V, f=250kHz	
Effective output capacitance, energy related <sup>1)</sup>	$C_{ m o(er)}$	-	101	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =0400V	
Effective output capacitance, time related <sup>2)</sup>	C <sub>o(tr)</sub>	-	1050	-	pF	$I_D$ =constant, $V_{GS}$ =0V, $V_{DS}$ =0400V	
Turn-on delay time	$t_{ m d(on)}$	-	13	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =15.9A, $R_{\rm G}$ =3.3 $\Omega$ ; see table 9	
Rise time	t <sub>r</sub>	-	7	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =15.9A, $R_{\rm G}$ =3.3 $\Omega$ ; see table 9	
Turn-off delay time $t_{ ext{d(off)}}$		-	64	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =15.9A, $R_{\rm G}$ =3.3 $\Omega$ ; see table 9	
Fall time	t <sub>f</sub>	-	3.8	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =15.9A, $R_{\rm G}$ =3.3 $\Omega$ ; see table 9	

Table 6 Gate charge characteristics

Parameter	Cymphal	Values			11	Note / Test Condition	
	Symbol	Min. Typ. Max.		Unit			
Gate to source charge	Q <sub>gs</sub>	-	14	-	nC	$V_{DD}$ =400V, $I_{D}$ =15.9A, $V_{GS}$ =0 to 10V	
Gate to drain charge	$Q_{\mathrm{gd}}$	-	23	-	nC	$V_{DD}$ =400V, $I_{D}$ =15.9A, $V_{GS}$ =0 to 10V	
Gate charge total	$Q_{g}$	-	68	-	nC	$V_{DD}$ =400V, $I_{D}$ =15.9A, $V_{GS}$ =0 to 10V	
Gate plateau voltage	V <sub>plateau</sub>	-	5.0	-	V	$V_{DD}$ =400V, $I_{D}$ =15.9A, $V_{GS}$ =0 to 10V	

 $<sup>^{1)}</sup>$   $C_{\text{o(er)}}$  is a fixed capacitance that gives the same stored energy as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 400V  $^{2)}$   $C_{\text{o(tr)}}$  is a fixed capacitance that gives the same charging time as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 400V





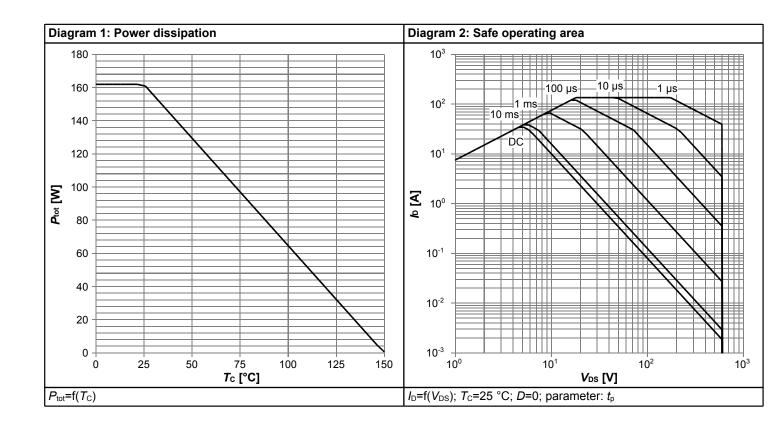
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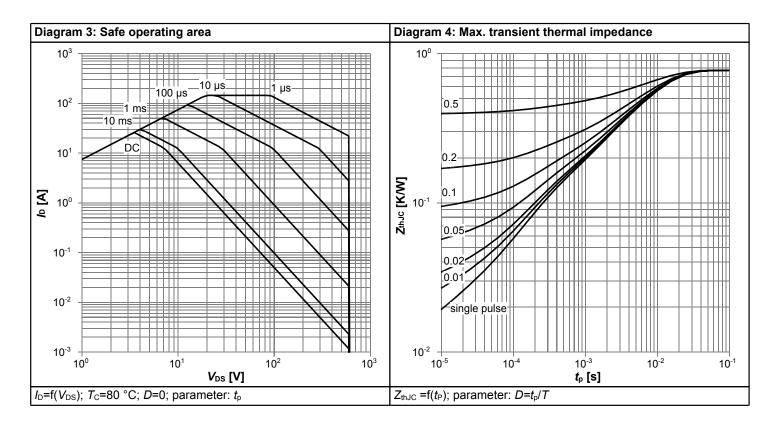
### Table 7 Reverse diode characteristics

Doromotor	Cumbal	Values			Unit	Note / Took Condition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Diode forward voltage	V <sub>SD</sub>	-	0.9	-	V	V <sub>GS</sub> =0V, I <sub>F</sub> =15.9A, T <sub>j</sub> =25°C	
Reverse recovery time	t <sub>rr</sub>	-	390	-	ns	$V_R$ =400V, $I_F$ =15.9A, $di_F/dt$ =100A/ $\mu$ s; see table 8	
Reverse recovery charge	Q <sub>rr</sub>	-	6	-	μC	$V_R$ =400V, $I_F$ =15.9A, $di_F/dt$ =100A/ $\mu$ s; see table 8	
Peak reverse recovery current	I <sub>rrm</sub>	-	32	-	А	$V_R$ =400V, $I_F$ =15.9A, $di_F/dt$ =100A/ $\mu$ s; see table 8	

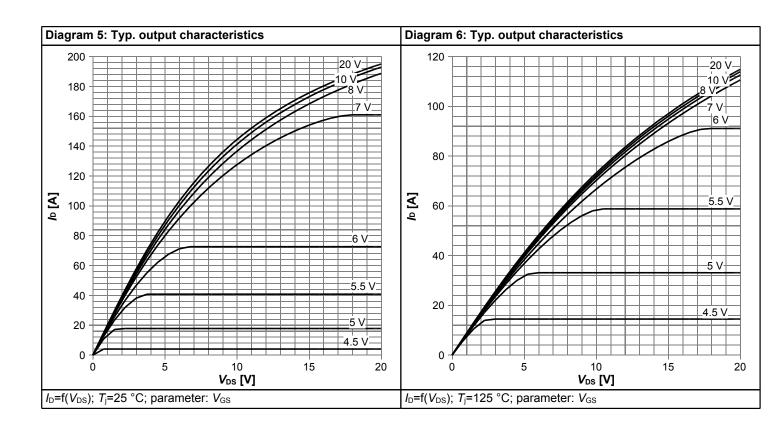


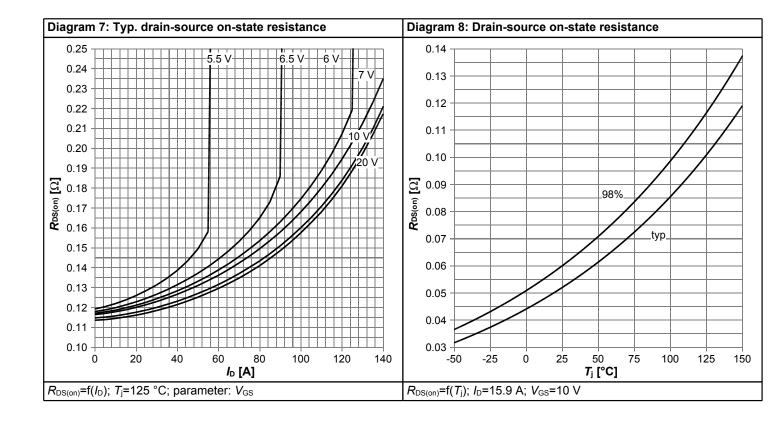
### 5 Electrical characteristics diagrams



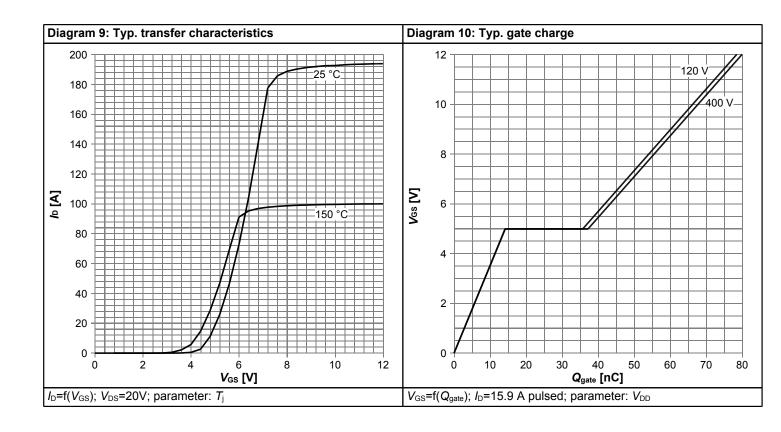


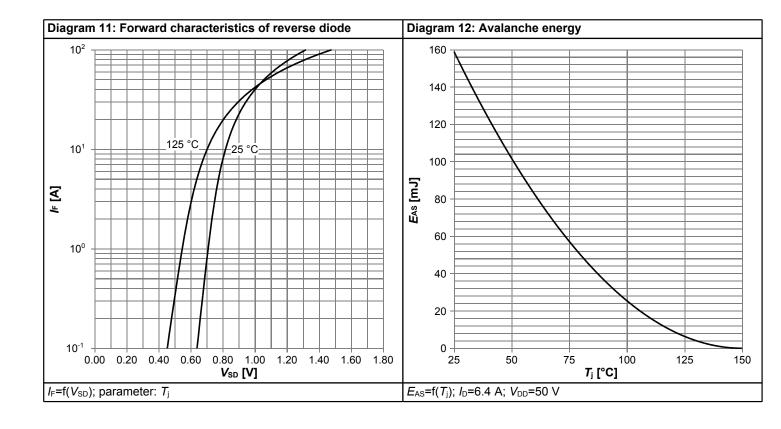




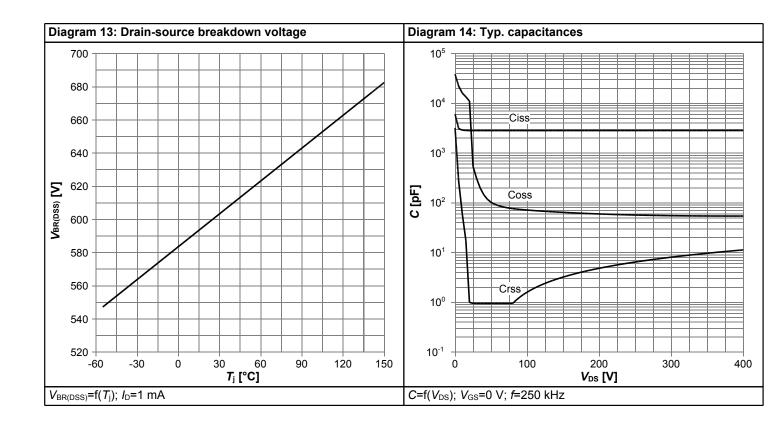


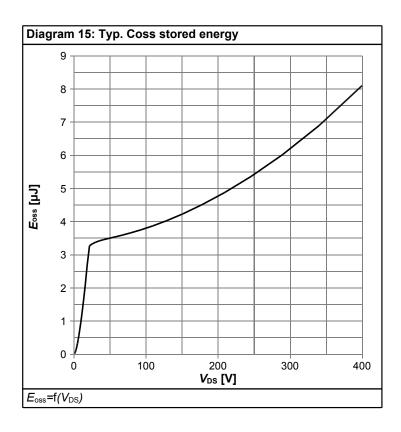














### 6 Test Circuits

Table 8 Diode characteristics

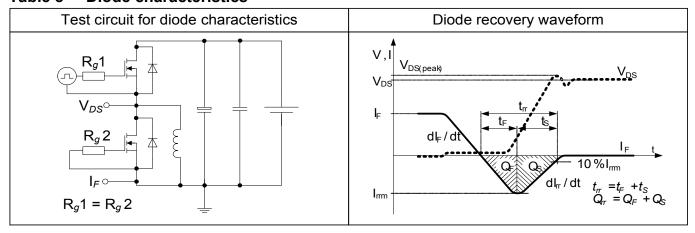


Table 9 switching times (ss)

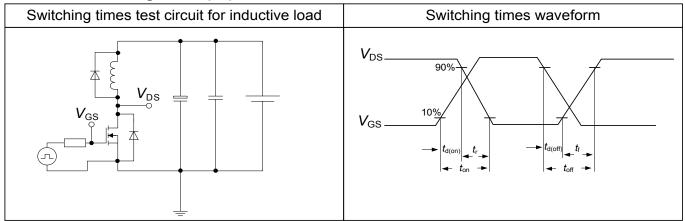
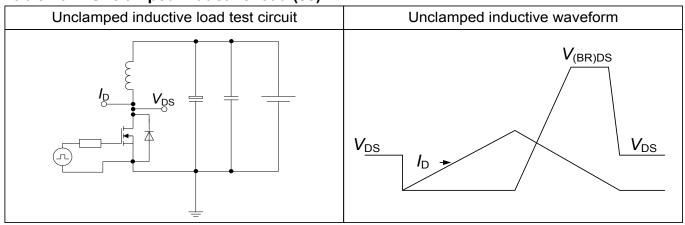
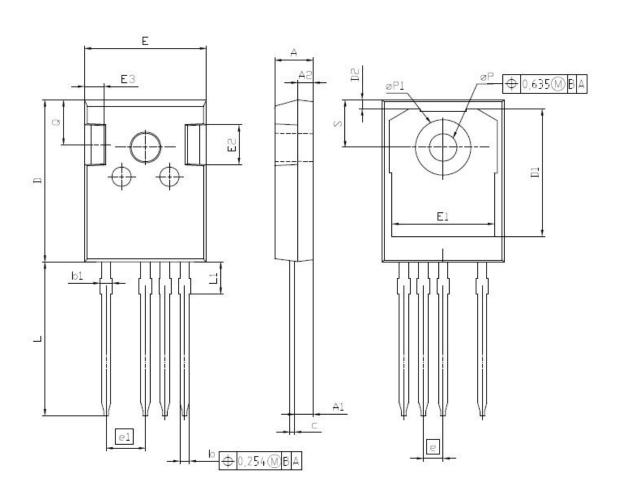


Table 10 Unclamped inductive load (ss)





## 7 Package Outlines



DIM MILLIMETERS			INCI	HES	
DIM	MIN	MAX	MIN	MAX	
Α	4.83	5.21	0.190	0.205	
A1	2.29	2.54	0.090	0.100	
A2	1.90	2.16	0.075	0.085	
b	1.07	1.33	0.042	0.052	
b1	1.10	1.70	0.043	0.067	
С	0.50	0.70	0.020	0.028	
D	20.80	21.10	0.819	0.831	
D1	16.25	17.65	0.640	0.695	
D2	0.95	1.35	0.037	0.053	
E	15.70	16.13	0.618	0.635	
E1	13.10	14.15	0.516	0.557	
E2	3.68	5.10	0.145	0.201	
E3	1.00	2.60	0.039	0.102	
е	2.54 (BSC)		0.100 (BSC)		
e1	5.	08	0.2	00	
N		4		4	
L	19.72	20.32	0.776	0.800	
L1	4.02	4.40	0.158	0.173	
øP	3.50	3.70	0.138	0.146	
øP1	7.00	7.40	0.276	0.291	
Q	5.49	6.00	0.216	0.236	
S	6.04	6.30	0.238	0.248	

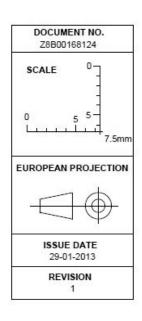


Figure 1 Outline PG-TO 247-4



### 8 Appendix A

### Table 11 Related Links

- IFX CoolMOS<sup>™</sup> C7 Webpage: <u>www.infineon.com</u>
- IFX CoolMOS<sup>™</sup> C7 application note: <u>www.infineon.com</u>
- IFX CoolMOS<sup>™</sup> C7 simulation model: www.infineon.com
- IFX Design tools: www.infineon.com



#### 600V CoolMOS™ C7 Power Transistor

IPZ60R060C7

#### **Revision History**

IPZ60R060C7

Revision: 2015-11-30, Rev. 2.0

Previous Revision						
Revision	Date	Subjects (major changes since last revision)				
2.0	2015-11-30	Release of final version				

#### We Listen to Your Comments

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